

Notice of References Cited	Application/Control No. 10/552,814	Applicant(s)/Patent Under Reexamination THELEN ET AL.	
	Examiner Phung T. Nguyen	Art Unit 2612	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,498,628	12-2002	Iwamura, Ryuichi	348/734
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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